

Search Notes

Application/Control No.

10/547,332

Examiner

Evan Dzierzynski

Applicant(s)/Patent under
Reexamination

YAMASHITA ET AL.

Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	611	12/13/2006	ED
	615	12/13/2006	ED
	620	12/13/2006	ED
	625	12/13/2006	ED
	626	12/13/2006	ED
	331	12/13/2006	ED

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Ali Alavi	12/13/2006	ED
EAST word search, attached	12/13/2006	ED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner